

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination TOFFLE ET AL.	
		Examiner Brian E. Miller	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,628,384	12-1986	Raj et al.	360/99.08
*	B	US-2004/0013327	01-2004	Mukai et al.	384/100
*	C	US-5,073,036	12-1991	Sutton et al.	384/107
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	E	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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